

Search Notes

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Soon D. Hyun

Applicant(s)/Patent under
Reexamination

YIP ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
370/229,230,389,392,401,464- 467,470,471,475; text search only-see search history printout	7/24/2007	HY